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DEPARTMENT OF COMMERCE

International Trade Administration

Medical University of South Carolina, et al.

Notice of Consolidated Decision on Applications
for Duty-Free Entry of Electron Microscope

This is a decision consolidated pursuant to Section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, as amended by Pub. L. 106-36; 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 A.M. and 5:00 P.M. in Room 3720, U.S. Department of Commerce, 14th and Constitution Avenue, NW, Washington, D.C.

Docket Number: 12-025. Applicant: Medical University of South Carolina, Charleston, SC 29403. Instrument: Electron Microscope. Manufacturer: JEOL, Ltd., Japan. Intended Use: See notice at 77 FR 39683, July 5, 2012.

Docket Number: 12-027. Applicant: University of Wyoming,

Laramie, WY 82071. Instrument: Electron Microscope.
Manufacturer: FEI Company, Czech Republic. Intended Use:
See notice at 77 FR 39683, July 5, 2012.

Docket Number: 12-028. Applicant: Air Force Institute of
Technology, Wright-Patterson AFB, OH 45433-7765.

Instrument: Electron Microscope. Manufacturer: FEI
Company, Czech Republic. Intended Use: See notice at 77 FR
39683, July 5, 2012.

Docket Number: 12-031. Applicant: Penn State College of
Medicine, Hershey, PA 17033. Instrument: Electron
Microscope. Manufacturer: JEOL, Ltd., Japan. Intended
Use: See notice at 77 FR 39683, July 5, 2012.

Comments: None received. Decision: Approved. No
instrument of equivalent scientific value to the foreign
instrument, for such purposes as this instrument is intended
to be used, is being manufactured in the United States at
the time the instrument was ordered. Reasons: Each foreign
instrument is an electron microscope and is intended for
research or scientific educational uses requiring an
electron microscope. We know of no electron microscope, or

any other instrument suited to these purposes, which was being manufactured in the United States at the time of order of each instrument.

Gregory W. Campbell
Director
Subsidies Enforcement Office
Import Administration

_July 26, 2012_____

Date

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